

#### **Description**

The XPX80P04D uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

 $V_{DS} = -40V I_{D} = -80 A$ 

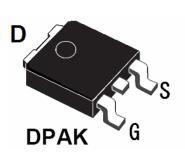
 $R_{DS(ON)} < -10 m\Omega$  @  $V_{GS}$ =-10V (Type: 7.0m $\Omega$ )

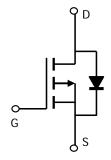
#### **Application**

Battery protection

Load switch

Uninterruptible power supply





**Package Marking and Ordering Information** 

Product ID	Pack	Marking	Qty(PCS)
XPX80P04D	TO-252-3L	XPX80P04D XXX YYYY	2500

Absolute Maximum Ratings (TC=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-40	V
Vgs	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-80	А
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-56	Α
Ірм	Pulsed Drain Current <sup>2</sup>	-280	Α
EAS	Single Pulse Avalanche Energy <sup>3</sup>	500	mJ
las	Avalanche Current	-50	Α
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	52.1	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range -55 to 150		°C
$R_{\theta}$ JA	Thermal Resistance Junction-Ambient <sup>1</sup>	62	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	2.4	°C/W



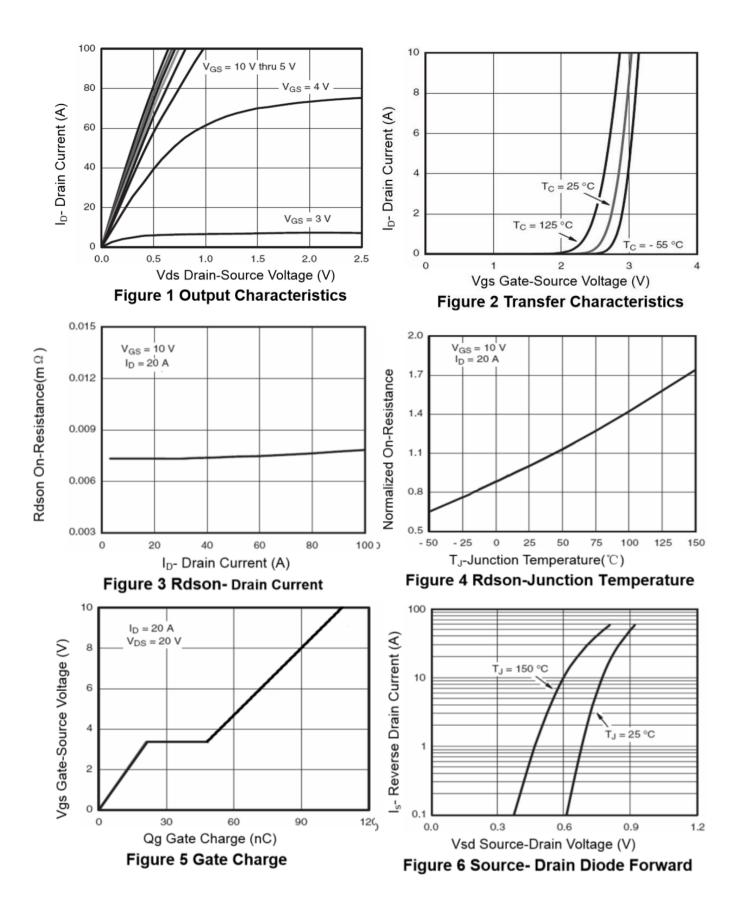
### Electrical Characteristics (T<sub>J</sub>=25℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVpss	Drain-Source Breakdown Voltage	Voltage V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA		-44		V	
△BVdss/△TJ	BV <sub>DSS</sub> Temperature Coefficient Reference to 25°C , I <sub>D</sub> =-1mA			-0.023		V/°C	
_		V <sub>GS</sub> =-10V , I <sub>D</sub> =-12A		7.0	10	_	
Rds(on)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-12A		9.0	15	mΩ	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1.2	-1.8	-2.5	V	
Ipss	Drain Source Leakage Current	V <sub>DS</sub> =-40V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA	
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =-40V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5		
Igss	Gate-Source Leakage Current	$V_{GS}$ =±20 $V$ , $V_{DS}$ =0 $V$			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =-15V , I <sub>D</sub> =-12A		20		S	
$R_g$	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		7	14	Ω	
$Q_g$	Total Gate Charge (-4.5V)			27.9			
Qgs	Gate-Source Charge	V <sub>DS</sub> =-20V , V <sub>GS</sub> =-10V , I <sub>D</sub> =-12A		7.7		nC	
$Q_{gd}$	Gate-Drain Charge			7.5			
Td(on)	Turn-On Delay Time			40			
Tr	Rise Time	$V_{DD}$ =-20V , $V_{GS}$ =-10V , $R_{G}$ =3.0 $\Omega$ ,		35.2		ne	
Td(off)	Turn-Off Delay Time	I <sub>D</sub> =-12A		100		ns	
$T_f$	Fall Time			9.6			
Ciss	Input Capacitance			6500			
Coss	Output Capacitance	V <sub>DS</sub> =-20V , V <sub>GS</sub> =0V , f=1MHz		790		pF	
Crss	Reverse Transfer Capacitance			605			
ls	Continuous Source Current <sup>1,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-70	Α	
Vsp	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1.2	V	

#### Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2. The data tested by pulsed , pulse width  $\leq 300 \text{us}$  , duty cycle  $\leq 2\%$
- 3 The EAS data shows Max. rating . The test condition is VDD=-32V,VGS=-10V,L=0.1mH,IAS=-50A
- $5\sqrt{100}$  The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.







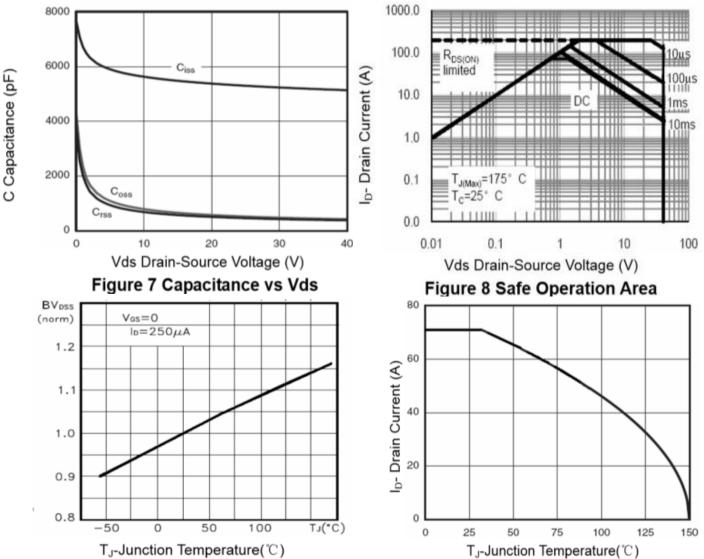


Figure 9 BV<sub>DSS</sub> vs Junction Temperature

Figure 10 ID Current Derating vs Junction Temperature

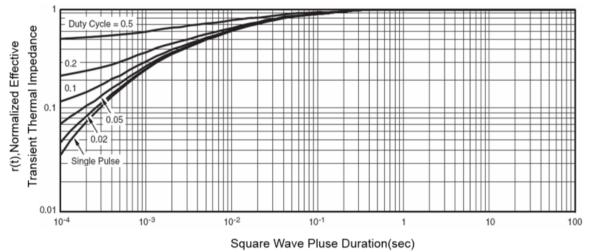
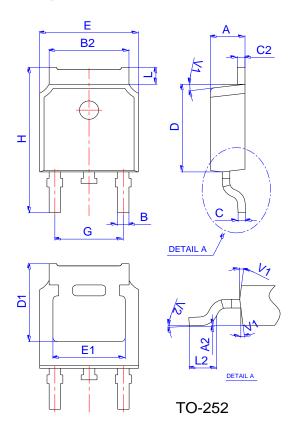


Figure 11 Normalized Maximum Transient Thermal Impedance

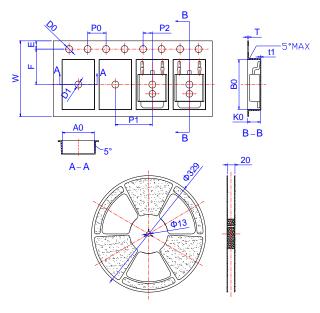


# Package Mechanical Data: TO-252-3L



	Dimensions						
Ref.		Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α	2.10		2.50	0.083		0.098	
A2	0		0.10	0		0.004	
В	0.66		0.86	0.026		0.034	
B2	5.18		5.48	0.202		0.216	
С	0.40		0.60	0.016		0.024	
C2	0.44		0.58	0.017		0.023	
D	5.90		6.30	0.232		0.248	
D1	5.30REF			0.209REF			
E	6.40		6.80	0.252		0.268	
E1	4.63			0.182			
G	4.47		4.67	0.176		0.184	
Н	9.50		10.70	0.374		0.421	
L	1.09		1.21	0.043		0.048	
L2	1.35		1.65	0.053		0.065	
V1		7°			7°		
V2	0°		6°	0°		6°	

# **Reel Spectification-TO-252**



	Dimensions						
Ref.		Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.	
W	15.90	16.00	16.10	0.626	0.630	0.634	
E	1.65	1.75	1.85	0.065	0.069	0.073	
F	7.40	7.50	7.60	0.291	0.295	0.299	
D0	1.40	1.50	1.60	0.055	0.059	0.063	
D1	1.40	1.50	1.60	0.055	0.059	0.063	
P0	3.90	4.00	4.10	0.154	0.157	0.161	
P1	7.90	8.00	8.10	0.311	0.315	0.319	
P2	1.90	2.00	2.10	0.075	0.079	0.083	
A0	6.85	6.90	7.00	0.270	0.271	0.276	
В0	10.45	10.50	10.60	0.411	0.413	0.417	
K0	2.68	2.78	2.88	0.105	0.109	0.113	
Т	0.24		0.27	0.009		0.011	
t1	0.10			0.004			
10P0	39.80	40.00	40.20	1.567	1.575	1.583	



Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time		
Pb device	<b>245℃±5</b> ℃	5sec±1sec		
Pb-Free device	260℃+0/-5℃	5sec±1sec		



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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